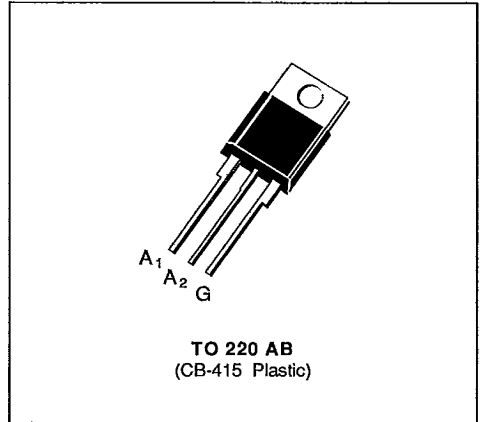


**SNUBBERLESS TRIACS**

- $I_{TRMS} = 8\text{ A}$  at  $T_c = 95\text{ °C}$ .
- $V_{DRM} : 200\text{ V}$  to  $800\text{ V}$ .
- $I_{GT} = 75\text{ mA}$  (QI-II-III).
- GLASS PASSIVATED CHIP.
- HIGH SURGE CURRENT :  $I_{TSM} = 80\text{ A}$ .
- HIGH COMMUTATION CAPABILITY :  
 $(di/dt)_c > 10\text{ A/ms}$  without snubber.


**DESCRIPTION**

New range suited for applications such as phase control and static switching on inductive or resistive load.

**ABSOLUTE RATINGS** (limiting values)

Symbol	Parameter		Value	Unit
$I_{TRMS}$	RMS on-state current (360 ° conduction angle)	$T_c = 95\text{ °C}$	8	A
$I_{TSM}$	Non repetitive surge peak on-state current ( $T_j$ initial = $25\text{ °C}$ )	$t = 8.3\text{ ms}$	85	A
		$t = 10\text{ ms}$	80	
$I^2t$	$I^2t$ value	$t = 10\text{ ms}$	32	$\text{A}^2\text{s}$
$di/dt$	Critical rate of rise of on-state current (1)	Repetitive $F = 50\text{ Hz}$	20	$\text{A}/\mu\text{s}$
		Non Repetitive	100	
$T_{stg}$ $T_j$	Storage and operating junction temperature range		- 40, + 150	$^{\circ}\text{C}$
			- 40, + 125	$^{\circ}\text{C}$

Symbol	Parameter	BTB 08-					Unit
		200 AW	400 AW	600 AW	700 AW	800 AW	
$V_{DRM}$	Repetitive peak off-state voltage (2)	$\pm 200$	$\pm 400$	$\pm 600$	$\pm 700$	$\pm 800$	V

(1) Gate supply :  $I_G = 750\text{ mA}$  -  $di_G / dt = 1\text{ A} / \mu\text{s}$ .

(2)  $T_j = 125\text{ °C}$ .

## THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
$R_{th(j-a)}$	Junction to ambient	60	°C/W
$R_{th(j-c)}$ DC	Junction to case for DC	3.5	°C/W
$R_{th(j-c)}$ AC	Junction to case for 360 ° conduction angle (F = 50 Hz)	2.7	°C/W

## GATE CHARACTERISTICS (maximum values)

$P_{GM} = 40$  W ( $t = 10$   $\mu$ s)  $P_{G(AV)} = 1$  W  $I_{GM} = 4$  A ( $t = 10$   $\mu$ s)  $V_{GM} = 16$  V ( $t = 10$   $\mu$ s).

## ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions		Quadrants	Min.	Typ.	Max.	Unit
$I_{GT}$	$T_j = 25$ °C Pulse duration > 20 $\mu$ s	$V_D = 12$ V $R_L = 33$ $\Omega$	I-II-III	2		75	mA
$V_{GT}$	$T_j = 25$ °C Pulse duration > 20 $\mu$ s	$V_D = 12$ V $R_L = 33$ $\Omega$	I-II-III			1.5	V
$V_{GD}$	$T_j = 125$ °C Pulse duration > 20 $\mu$ s	$V_D = V_{DRM}$ $R_L = 3.3$ k $\Omega$	I-II-III	0.2			V
$I_H^*$	$T_j = 25$ °C Gate open	$I_T = 100$ mA $R_L = 140$ $\Omega$				75	mA
$I_L$	$T_j = 25$ °C Pulse duration > 20 $\mu$ s	$V_D = 12$ V $I_G = 500$ mA	I-III		75		mA
			II		150		
$V_{TM}^*$	$T_j = 25$ °C	$I_{TM} = 11$ A				1.75	V
$I_{DRM}^*$	$T_j = 25$ °C	$V_{DRM}$ rated Gate open				0.01	mA
	$T_j = 125$ °C				2		
$dv/dt^*$	$T_j = 125$ °C Linear slope up to 0.67 $V_{DRM}$	Gate open		750	1000		V/ $\mu$ s
$(di/dt)_c^*$	$T_j = 125$ °C Without snubber	$V_{DRM}$ rated		10	20		A/ms
$t_{gt}$	$T_j = 25$ °C	$di_G/dt = 3.5$ A/ $\mu$ s $V_D = V_{DRM}$	I-II-III			2	$\mu$ s
	$I_T = 11$ A						

\* For either polarity of electrode A<sub>2</sub> voltage with reference to electrode A<sub>1</sub>.

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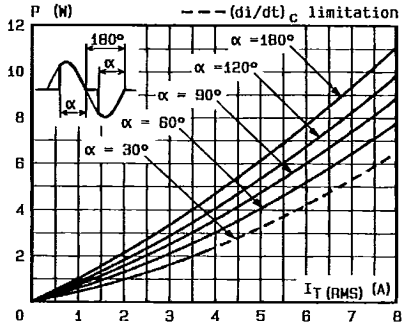


Fig.1 - Maximum mean power dissipation versus RMS on-state current ( $F = 60$  Hz).

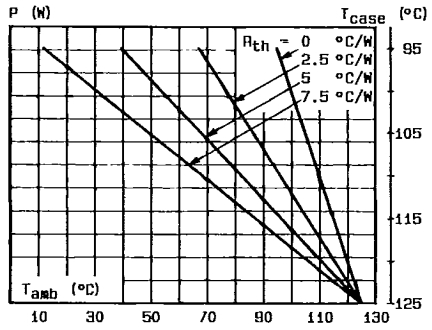


Fig.2 - Correlation between maximum mean power dissipation and maximum allowable temperatures ( $T_{amb}$  and  $T_{case}$ ) for different thermal resistances heatsink + contact.

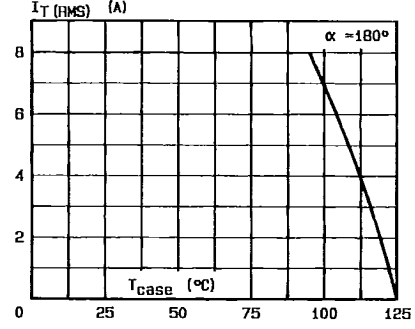


Fig.3 - RMS on-state current versus case temperature.

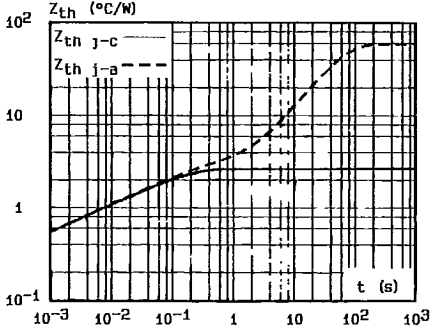


Fig.4 - Thermal transient impedance junction to case and junction to ambient versus pulse duration.

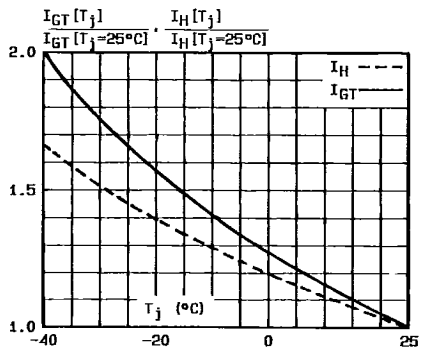


Fig.5 - Relative variation of gate trigger current and holding current versus junction temperature.

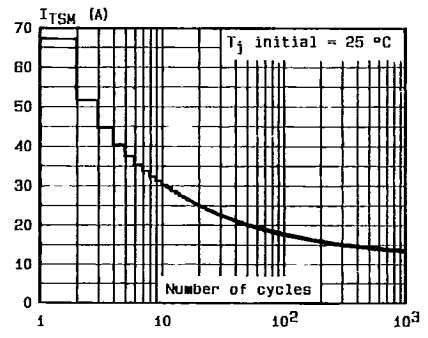


Fig.6 - Non repetitive surge peak on-state current versus number of cycles.



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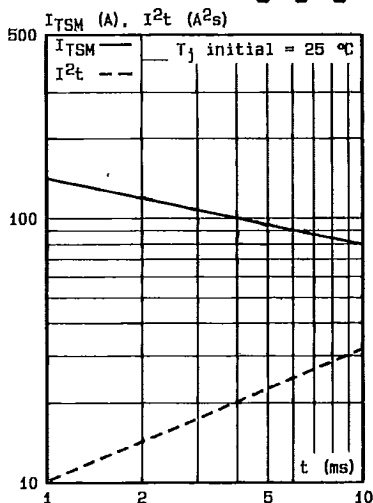


Fig.7 - Non repetitive surge peak on-state current for a sinusoidal pulse with width :  $t \leq 10$  ms, and corresponding value of  $I^2t$ .

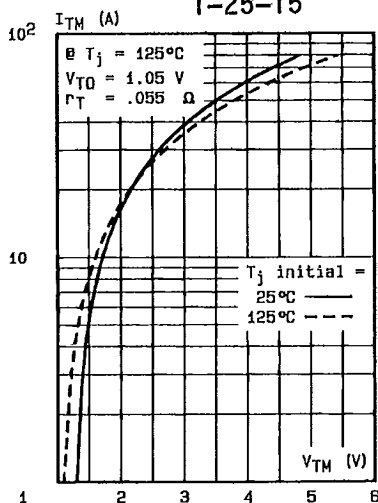
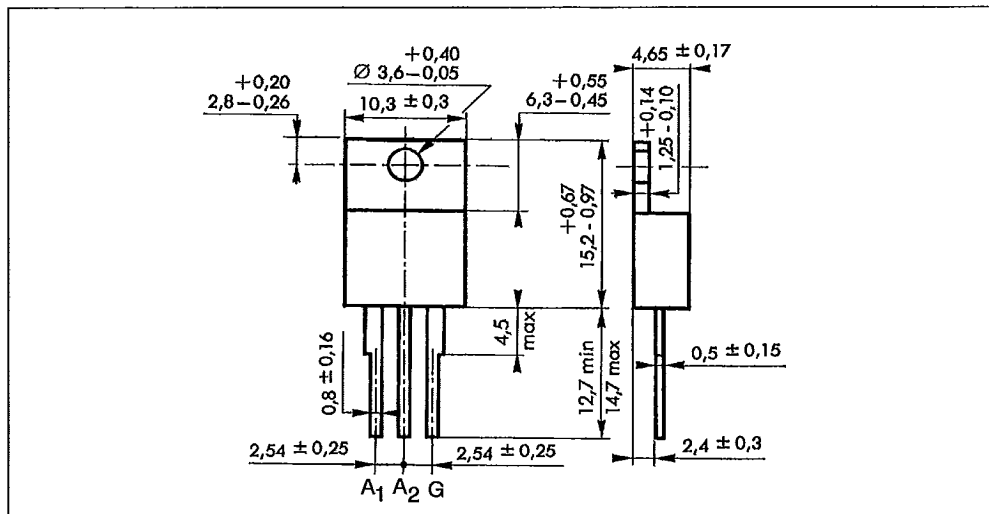


Fig.8 - On-state characteristics (maximum values).

PACKAGE MECHANICAL DATA

TO 220 AB (CB-415) Plastic



Cooling method : by conduction (method C)  
 Marking : type number  
 Weight : 2 g